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·			Docket Num!	Application Number	
	5	INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)	11188.00		o E
	•		Applicant(s) Kyung Joo	on Han et al.	3951 3951
		#2	Filing Date November 8, 2001	Group Art Unit 2818	10/0
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U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MY	A	5,060,195	10/22/91	Gill et al.			
1	В	5,418,741	05/23/95	Gill			
	C	5,487,033	01/23/96	Keeney et al.			
	D	5,546,340	08/13/96	Hu et al.			
	Е	5,553,020	09/03/96	Keeney et al.			
	F	5,646,886	07/08/97	Brahmbhatt			
	G	5,659,504	08/19/97	Bude et al.			
	H	5,959,892	09/28/99	Lin et al.			
mr	I	6,175,519	01/16/01	Lu et al.			

FOREIGN PATENT DOCUMENTS

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANS	LATION
							YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

HW	J	J. D. Bude et al.; Monte Carlo Simulation of the CHISEL Flash Memory Cell; IEEE Transactions on Electron Devices, Vol. 47, No. 10, October 2000; p. 1873-1881				
imo	K	J.D. Bude et al.; <u>EEPROM/Flash Sub 5.0V Drain-Source Bias Hot Carrier Writing</u> , IEDM Technical Digest, 1995, p. 989-991				
pm	Ĺ	J.D. Bude et al.; Secondary Electron Flash – a High Performance, Low Power Flash Technology for 0.35 µm and Below; IEDM Technical Digest, 1997, p. 279-282				
EXAMINER		H. Ho DATE CONSIDERED March 4,2003				
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609, Draw line through citation if not inconformance and not considered						
Include copy of this form with next communication to applicant.						